

January 2008

# FGPF50N30T 300V, 50A PDP IGBT

#### **Features**

- · High current capability
- Low saturation voltage: V<sub>CE(sat)</sub> =1.4V @ I<sub>C</sub> = 30A
- · High input impedance
- Fast switching
- · RoHS compliant

### **Applications**

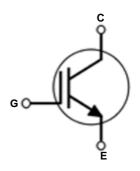
• PDP System



### **General Description**

Using Novel Trench IGBT Technology, Fairchild's new sesries of trench IGBTs offer the optimum performance for PDP applications where low conduction and switching losses are essential.





## **Absolute Maximum Ratings**

Symbol	Description		Ratings	Units	
V <sub>CES</sub>	Collector to Emitter Voltage		300	V	
V <sub>GES</sub>	Gate to Emitter Voltage		± 30	V	
I <sub>CM (1)</sub>	Pulsed Collector Current	@ T <sub>C</sub> = 25°C	120	А	
$P_{D}$	Maximum Power Dissipation	$@ T_C = 25^{\circ}C$	46.8	W	
	Maximum Power Dissipation	$@ T_C = 100^{\circ}C$	18.7	W	
T <sub>J</sub>	Operating Junction Temperature		-55 to +150	°C	
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	-	2.67	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	62.5	°C/W

#### Notes

1: Repetitive test , Pulse width=100usec , Duty=0.1

<sup>\*</sup> I<sub>C</sub>\_pluse limited by max Tj

# **Package Marking and Ordering Information**

			Packaging		Max Qty
<b>Device Marking</b>	Device	Package	Туре	Qty per Tube	per Box
FGPF50N30T	FGPF50N30TTU	TO-220F	Rail / Tube	50ea	-

# Electrical Characteristics of the IGBT $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics					
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250 \mu A$	300	-	-	V
ΔΒV <sub>CES</sub> ΔΤ <sub>J</sub>	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0V, I_C = 250\mu A$	-	0.3	-	V/ºC
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$	-	-	250	μА
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$	-	-	±400	nA
On Charac	eteristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_{C} = 250 \mu A, V_{CE} = V_{GE}$	3.0	4.5	5.5	V
		I <sub>C</sub> = 15A, V <sub>GE</sub> = 15V	-	1.1	1.5	V
V	Collector to Emittor Saturation Valtage	I <sub>C</sub> = 30A, V <sub>GE</sub> = 15V	-	1.4	-	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	$I_C = 50A$ , $V_{GE} = 15V$ , $T_C = 25^{\circ}C$	-	1.65	-	V
		I <sub>C</sub> = 50A, V <sub>GE</sub> = 15V, T <sub>C</sub> = 125°C	-	1.60	-	V
Dynamic C	Characteristics Input Capacitance		-	2320	-	pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 30V_{V_{GE}} = 0V_{V_{CE}}$	_	92	_	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz	-	80	_	pF
	Characteristics					-
t <sub>d(on)</sub>	Turn-On Delay Time		_	31	_	ns
t <sub>r</sub>	Rise Time	$V_{CC}$ = 200V, $I_{C}$ = 30A, $R_{G}$ = 15 $\Omega$ , $V_{GE}$ = 15V, Resistive Load, $T_{C}$ = 25 $^{\circ}$ C	-	78	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	156	-	ns
t <sub>f</sub>	Fall Time		-	200	300	ns
t <sub>d(on)</sub>	Turn-On Delay Time		-	30	-	ns
t <sub>r</sub>	Rise Time	$V_{CC}$ = 200V, $I_{C}$ = 30A, $R_{G}$ = 15 $\Omega$ , $V_{GE}$ = 15V, Resistive Load, $T_{C}$ = 125°C	-	78	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	163	-	ns
t <sub>f</sub>	Fall Time		-	260	-	ns
Qg	Total Gate Charge		-	97	-	nC
Q <sub>ge</sub>	Gate to Emitter Charge	$V_{CE} = 200V, I_{C} = 30A,$ $V_{GE} = 15V$	-	15	-	nC
Q <sub>gc</sub>	Gate to Collector Charge	*GE = 10 V	_	41	1	nC

## **Typical Performance Characteristics**

Figure 1. Typical Output Characteristics

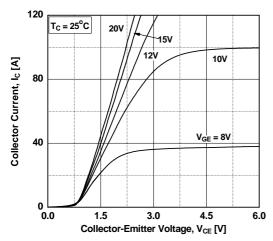


Figure 3. Typical Saturation Voltage Characteristics

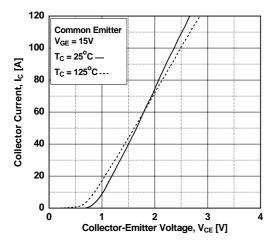
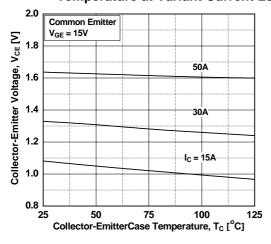


Figure 5. Saturation Voltage vs. Case
Temperature at Variant Current Level



**Figure 2. Typical Output Characteristics** 

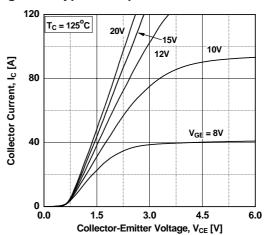


Figure 4. Transfer Characteristics

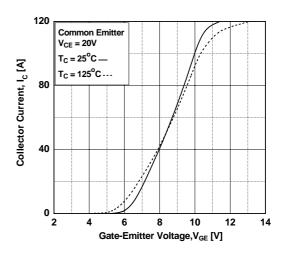
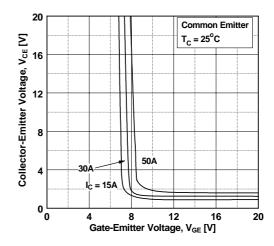


Figure 6. Saturation Voltage vs. V<sub>GE</sub>



# **Typical Performance Characteristics**

Figure 7. Saturation Voltage vs. V<sub>GE</sub>

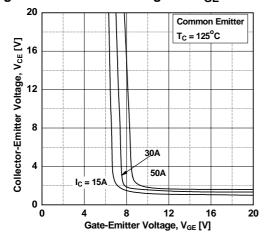


Figure 9. Gate charge Characteristics

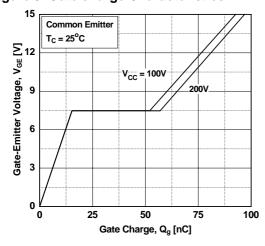
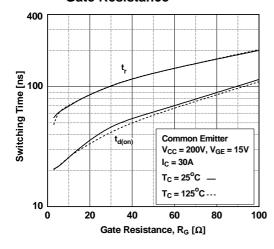


Figure 11. Turn-on Characteristics vs.
Gate Resistance



**Figure 8. Capacitance Characteristics** 

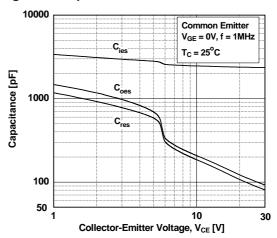


Figure 10. SOA Characteristics

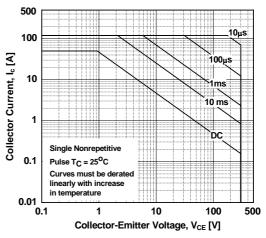
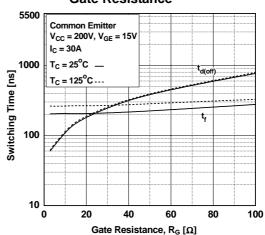


Figure 12. Turn-off Characteristics vs.
Gate Resistance



### **Typical Performance Characteristics**

Figure 13. Turn-on Characteristics vs. Collector Current

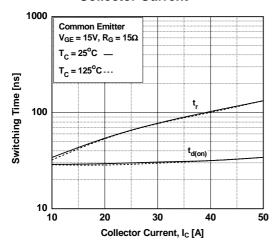


Figure 14. Turn-off Characteristics vs. Collector Current

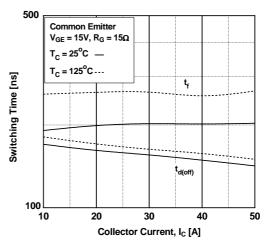


Figure 15. Switching Loss vs. Gate Resistance

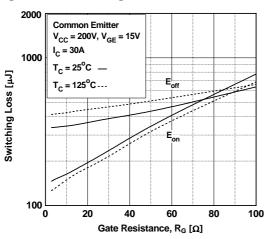


Figure 16. Switching Loss vs.Gate Resistance

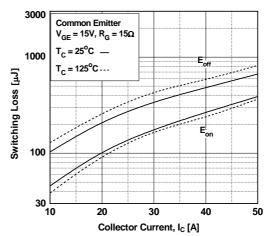
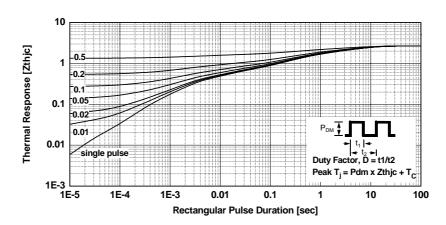
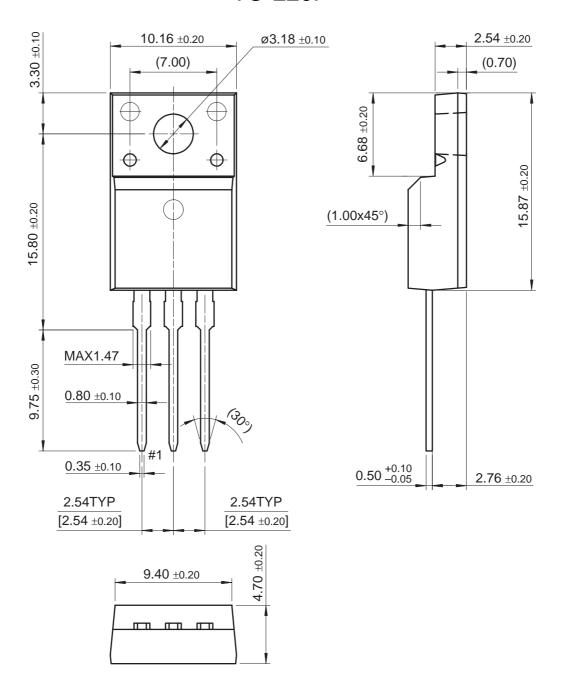


Figure 17.Transient Thermal Impedance of IGBT



## **Mechanical Dimensions**

# TO-220F



Dimensions in Millimeters





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